

Search Notes

Application/Control No.

10/520,169

Examiner

Shin-Lin Chen

Applicant(s)/Patent under
Reexamination

BACON ET AL.

Art Unit

1632

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| Updated. | 6/18/2007 | SLC |
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